

Search Notes

Application/Control No.

09/882,512

Examiner

Jason M. Perilla

Applicant(s)/Patent under
Reexamination

KEAVENEY ET AL.

Art Unit

2638

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 375 | 354 | 7/22/2005 | JP |
| | 362 | 7/22/2005 | JP |
| | 371 | 7/22/2005 | JP |
| | 373 | 7/22/2005 | JP |
| | 374 | 7/22/2005 | JP |
| | 375 | 7/22/2005 | JP |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 375 | 371 | 1/13/2006 | JP |
| | 373-376 | 1/13/2006 | JP |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-----------------------------------|-----------|------|
| East USPAT/USPGPUB EPO/JPO | 7/24/2005 | JP |
| Inventor Name Search East/EDAN | 1/13/2006 | JP |
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